303143, 303143L (Z-Foil)

Vishay Foil Resistors

Models 303143 and 303143L (Ultra High Precision Fixed Resistor Z-Foil Z201), Screen/Test Flow as modified from S-311-P813 Proposed by NASA



INTRODUCTION

VISHAY

GROUP

The 303143 (0.150" lead spacing) and 303143L (0.200" lead spacing) Bulk Metal[®] Z-Foil resistors represent the 3rd in a series of ultra-precision resistors since the first Bulk Metal Foil resistor was introduced by Vishay in 1962. Each represents an improvement on the earlier model. The TCR slope of the 303143 and 303143L is 0.2 ppm/°C (- 55 °C to + 125 °C, + 25 °C ref.) and is an order of magnitude better than the original S102C. The Bulk Metal Z-Foil resistor is the ultimate choice in the most demanding analog applications.

The Z-Foil technology provides a significant reduction of the resistive component's sensitivity to ambient temperature variations (TCR) and applied power changes (PCR). Designers can now guarantee a high degree of stability and accuracy in fixed-resistor applications using solutions based on Vishay's revolutionary Z-Foil technology.

Our application engineering department is available to advise and to make recommendations.

	OLERANCE ESISTANCE	AND TCR VS.
VALUE	TIGHTEST ABSOLUTE TOLERANCES	TYPICAL TCR AND MAXIMUM SPREAD - 55 °C TO + 125 °C (+ 25 °C ref.)
100 Ω to 100 k Ω	± 0.005 %	± 0.2 ± 0.6 ppm/°C
80 Ω to < 100 Ω	± 0.005 %	± 0.2 ± 0.8 ppm/°C
50 Ω to < 80 Ω	± 0.005 %	± 0.2 ± 1.0 ppm/°C
25 Ω to < 50 Ω	± 0.01 %	± 0.2 ± 1.3 ppm/°C
10 Ω to < 25 Ω	± 0.05 %	± 0.2 ± 1.6 ppm/°C

FEATURES

- Temperature coefficient of resistance (TCR):
 ± 0.05 ppm/°C typical (0 °C to + 60 °C)
 - \pm 0.2 ppm/°C typical (- 55 °C to + 125 °C, + 25 °C ref.)
- Power coefficient of resistance "∆R due to self heating": ± 5 ppm at rated power
- Rated power: 0.6 W at 70 °C 0.3 W at 125 °C
- Resistance tolerance: to \pm 0.005 %
- Load life stability: to \pm 0.005 % at 70 °C, 2000 h at rated power
- Resistance range: 10 Ω to 100 k Ω
- Electrostatic discharge (ESD) up to 25 000 V
- Non-inductive, non-capacitive design
- Rise time: 1.0 ns effectively no ringing
- Current noise: 0.010 μV_{RMS}/V of applied voltage (< 40 dB)
- Thermal EMF: 0.1 μ V/°C max. 0.05 μ V/°C typical
- Voltage coefficient: < 0.1 ppm/V
- Non-inductive: 0.08 μH
- Terminal finish: tin/lead alloy
- Maximum working voltage: 245 V
- Drop in replacement for S102C/K
- Matched sets are available per request
- For prototype units, append a "U" to the model number (example: 303143U). These units include only the 100 % screening requirements (table 4, page 4). For more information, please contact foil@vishaypg.com



303143, 303143L (Z-Foil)

Vishay Foil Resistors







		LS	w	L	н	ST	SW	LL
303143	Inches	0.150 ± 0.005						
303143	mm	3.81 ± 0.13	0.105 ± 0.010	0.300 ± 0.010	0.326 ± 0.010	0.010 min	0.035 ± 0.01	1.000 ± 0.125
303143L	Inches	0.200 ± 0.005	2.67 ± 0.25	7.62 ± 0.25	8.28 ± 0.25	0.254 min	1.02 ± 0.13	25.4 ± 3.18
303143L	mm	5.08 ± 0.13						

TABLE 2 - SPECIFICATIONS	
Stability	
Load Life at 2000 h	\pm 0.005 % max. ΔR at 0.1 W/+ 70 °C
	\pm 0.015 % max. ΔR at 0.3 W/+ 125 °C
Load Life at 10 000 h	± 0.01 % max. ∆R at 0.05 W/+ 125 °C
	± 0.05 % max. ∆R at 0.3 W/+ 125 °C



Vishay Foil Resistors

TABLE 3 - ENVIRONMENTAL PERFOR	MANCE COMPARI	SON	
	MIL-PRF-55182	VISHAY 303	143, 303143L
	CHAR J		
Test Group I Thermal Shock Short Time Overload	± 0.2 % ± 0.2 %	± 0.01 % (100 ppm) ± 0.03 % (300 ppm)	± 0.002 % (20 ppm) ± 0.003 % (30 ppm)
Test Group II Resistance Temperature Characteristic Low Temperature Storage Low Temperature Operation Terminal Strength	± 25 ppm/°C ± 0.15 % ± 0.15 % ± 0.2 %	see table 1 ± 0.01 % (100 ppm) ± 0.01 % (100 ppm) ± 0.01 % (100 ppm)	± 0.05 ppm/°C (0 °C to + 60 °C) ± 0.002 % (20 ppm) ± 0.002 % (20 ppm) ± 0.002 % (20 ppm)
Test Group III DWV Resistance to Solder Heat Moisture Resistance	± 0.15 % ± 0.1 % ± 0.4 %	± 0.01 % (100 ppm) ± 0.01 % (100 ppm) ± 0.02 % (200 ppm)	± 0.002 % (20 ppm) ± 0.005 % (50 ppm) ± 0.01 % (100 ppm)
Test Group IV Shock Vibration	± 0.2 % ± 0.2 %	± 0.01 % (100 ppm) ± 0.01 % (100 ppm)	± 0.002 % (20 ppm) ± 0.002 % (20 ppm)
Test Group V Life Test at 0.3 W/+ 125 °C 2000 h 10 000 h	± 0.5 % ± 2.0 %	± 0.015 % (150 ppm) ± 0.05 % (500 ppm)	± 0.01 % (100 ppm) ± 0.03 % (300 ppm)
Test Group Va Life Test at 0.6 W (2 x Rated Power)/+ 70 °C, 2000 h	± 0.5 %	± 0.015 % (150 ppm)	± 0.01 % (100 ppm)
Test Group VI High Temperature Exposure	± 2.0 %	± 0.05 % (500 ppm)	± 0.02 % (200 ppm)
Test Group VII Voltage Coefficient	0.005 %/V	< 0.00001 %/V	< 0.00001 %/V

STANDARD MEASUREMENT (at room temperature)

Standard Test Conditions:

- Temperature: + 23 °C ± 2 °C
- Relative humidity: 35 % RH to 65 % RH
- Lead test point: 0.5" (12.7 mm) from resistor body

NOTES

- For unqualified pre-flight or prototype units, use models # 303143U, 303143LU which include only the 100 % screening requirements
- Measurement error allowed for ΔR limits: 0.01 Ω

303143, 303143L (Z-Foil)

Vishay Foil Resistors



Group A 100 % RC record - in tolerance Thermal shock (MIL-STD-202 method 107 condition F-1) 25 x, - 65 °C, + 150 °C Overload (+ 25 °C, 6.25 x rated power, 5 s) RC record - in tolerance, AR = 0.03 % Power conditioning (+ 125 °C, 0.3 W, 100 h, not to exceed 245 V) RC record - in tolerance, AR = 0.05 % Subgroup 2 6 pieces, any value, electrical rejects allowed Solderability 3 pieces, any value, electrical rejects allowed Solderability 3 pieces or 100 %, any value, zero rejects allowed TCR (MIL-STD-202 method 304 with the following exceptions) - Final Group A inspection TCR (MIL-STD-202 method 304 with the following exceptions) Image: Comp B 13 pieces or 100 %, any value, zero rejects allowed Subgroup 1 TCR (MIL-STD-202 method 304 with the following exceptions) Image: Comp C - must maintain temperature for 30 min to 45 min before measurement Image: Figure B 13 pieces, any value, zero rejects allowed Subgroup 2 8 pieces, any value, zero rejects allowed Resistance to solvents - escind test temperatures, +25 °C, -15 °C °C Image: Figure B - escind test temperatures, +25 °C, -15 °C °C Image: Figure B 12 pieces (6 of the highest value, 6 of the lowest value), 0 rejects Sub	Group A	
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Subgroup 1 Overload (+ 25 °C, 6.25 x rated power, 5 s) RC record - in tolerance, AR = 0.03 % Power conditioning (+ 125 °C, 0.3 W, 100 h, not to exceed 245 V) RC record - in tolerance, AR = 0.05 % Visual inspection Final inspection - PDA - 5 % on AR = 0.05 % Subgroup 2 6 pieces, any value, electrical rejects allowed Subgroup 3 6 pieces, any value, electrical rejects allowed Subgroup 4 inspection Mechanical/dimensional evaluation Final Group A inspect Mechanical/dimensional evaluation Final Group A inspector TCR (MIL-STD-202 method 304 with the following exceptions) - must maintain temperatures to 30 min to 45 min before measurement - first test temperatures, +25 °C, -15 °C, -55 °C - second test temperatures, +25 °C, +15 °C, +55 °C - escond test temperatures, +25 °C, +165 °C - second test temperatures, +25 °C, +15 °C - escond test temperatures, +25 °C, +165 °C - second test temperatures, +25 °C, +15 °C, +125 °C - escond test temperatures, +25 °C, +165 °C - second test temperatures, +25 °C, +15 °C, +125 °C - escond test temperatures, +25 °C, +165 °C - second test temperatures, +25 °C, +165 °C - escond test temperatures, +25 °C, +165 °C - second test temperatures, +25 °C, +165 °C		RC record - in tolerance
RC record - in tolerance, ΔR = 0.05 % Visual inspection Final inspection - PDA - 5 % on ΔR = 0.05 % 6 pieces, any value, electrical rejects allowed Solderability 3 pieces, any value, non destructive Mechanical/dimensional evaluation Final Group A inspection Group B 13 pieces or 100 %, any value, zero rejects allowed TCR (MIL-STD-202 method 304 with the following exceptions) - must maintain temperature for 30 min to 45 min before measurement - first test temperatures, + 25 °C, -15 °C - second test temperatures, + 25 °C, -15 °C - second test temperatures, + 25 °C, + 125 °C - + 25 °C to be used as reference reading 8 pieces, any value, zero rejects allowed Group C Group A and B testing required Subgroup 1 12 pieces (6 of the highest value, 6 of the lowest value), 0 rejects Subgroup 1 Life - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %	Subgroup 1	Overload (+ 25 °C, 6.25 x rated power, 5 s)
Subgroup 2 6 pieces, any value, electrical rejects allowed Solderability Subgroup 3 3 pieces, any value, non destructive Mechanical/dimensional evaluation Final Group A inspection Mechanical/dimensional evaluation Group B 13 pieces or 100 %, any value, zero rejects allowed Subgroup 1 13 pieces or 100 %, any value, zero rejects allowed TCR (MIL-STD-202 method 304 with the following exceptions) - must maintain temperature for 30 min to 45 min before measurement - first test temperatures, + 25 °C, - 15 °C, - 55 °C - second test temperatures, + 25 °C, + 65 °C, + 125 °C - second test temperatures, + 25 °C, - 15 °C, - 55 °C - second test temperatures, + 25 °C, + 65 °C, + 125 °C - second test temperatures, + 25 °C, - 10 most as reference reading 8 pieces, any value, zero rejects allowed Resistance to solvents Group C Group A and B testing required 12 pieces (6 of the highest value, 6 of the lowest value), 0 rejects Subgroup 1 Life - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h 10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 % Point ΔR		RC record - in tolerance, $\Delta R = 0.05 \%$
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Subgroup 3 Mechanical/dimensional evaluation Final Group A inspector Image: Constraint of the problem of	Subgroup 2	
Group B13 pieces or 100 %, any value, zero rejects allowedTCR (MIL-STD-202 method 304 with the following exceptions) - must maintain temperature for 30 min to 45 min before measurement - first test temperatures, $+ 25 ^{\circ}$ C, $- 15 ^{\circ}$ C - second test temperatures, $+ 25 ^{\circ}$ C, $+ 65 ^{\circ}$ C, $+ 125 ^{\circ}$ C - $+ 25 ^{\circ}$ C to be used as reference readingSubgroup 28 pieces, any value, zero rejects allowed Resistance to solventsGroup A and B testing requiredSubgroup 1Life - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum $\Delta R - 0.015 ^{\circ}$ for 2000 h, 0.05 $^{\circ}$ for 10 000 hNote: (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. $\Delta R = 0.01 ^{\circ}$	Subgroup 3	
Subgroup 1 13 pieces or 100 %, any value, zero rejects allowed TCR (MIL-STD-202 method 304 with the following exceptions) - must maintain temperature for 30 min to 45 min before measurement - first test temperatures, + 25 °C, - 15 °C, - 55 °C - second test temperatures, + 25 °C, + 65 °C, + 125 °C - + 25 °C to be used as reference reading 8 pieces, any value, zero rejects allowed Resistance to solvents Resistance to solvents Group C 12 pieces (6 of the highest value, 6 of the lowest value), 0 rejects Life - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h 10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 % 12 pieces (5 high, 5 low)	Final Group A inspect	ion
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Subgroup 1- must maintain temperature for 30 min to 45 min before measurement - first test temperatures, $+25 ^{\circ}$ C, $-15 ^{\circ}$ C, $-55 ^{\circ}$ C - second test temperatures, $+25 ^{\circ}$ C, $+65 ^{\circ}$ C, $+125 ^{\circ}$ C - $+25 ^{\circ}$ C to be used as reference readingSubgroup 28 pieces, any value, zero rejects allowed Resistance to solventsGroup CI2 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsSubgroup 112 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsLife - (+125 ^{\circ}C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum $\Delta R - 0.015 ^{\circ}$ for 2000 h, 0.05 $^{\circ}$ for 10 000 hNote: In the exist of the solution of the solution of the test of test of the test of test of the test of the test of test of the test of test of test test test test test of test of test test test test test test test tes		13 pieces or 100 %, any value, zero rejects allowed
Subgroup 1- first test temperatures, $+ 25 ^{\circ}$ C, $- 15 ^{\circ}$ C, $- 55 ^{\circ}$ C - second test temperatures, $+ 25 ^{\circ}$ C, $+ 65 ^{\circ}$ C, $+ 125 ^{\circ}$ C - $+ 25 ^{\circ}$ C to be used as reference readingSubgroup 28 pieces, any value, zero rejects allowed Resistance to solventsGroup C12 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsSubgroup 112 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsLife - (+ 125 ^{\circ}C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum Δ R - 0.015 % for 2000 h, 0.05 % for 10 000 hOther C10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. Δ R = 0.01 %		TCR (MIL-STD-202 method 304 with the following exceptions)
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	Subgroup	- first test temperatures, + 25 °C, - 15 °C, - 55 °C
Subgroup 28 pieces, any value, zero rejects allowed Resistance to solventsGroup CGroup A and B testing required12 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsLife - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h0 block10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %		- second test temperatures, + 25 °C, + 65 °C, + 125 °C
Subgroup 2Resistance to solventsGroup CGroup A and B testing requiredSubgroup 112 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsLife - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum $\Delta R - 0.015$ % for 2000 h, 0.05 % for 10 000 hImage: Delta of the sistance to soldering heat (conditions A and C), max. $\Delta R = 0.01$ %		- + 25 °C to be used as reference reading
Group CGroup A and B testing required12 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsLife - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %	Subgroup 2	8 pieces, any value, zero rejects allowed
Group A and B testing requiredSubgroup 112 pieces (6 of the highest value, 6 of the lowest value), 0 rejectsLife - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %		Resistance to solvents
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Subgroup 1 Life - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h 10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %	Group A and B testing	
RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h 10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %	0	
Maximum ΔR - 0.015 % for 2000 h, 0.05 % for 10 000 h 10 pieces (5 high, 5 low), 1 reject allowed Resistance to soldering heat (conditions A and C), max. ΔR = 0.01 %	Subgroup 1	
Resistance to soldering heat (conditions A and C), max. $\Delta R = 0.01$ %		
		10 pieces (5 high, 5 low), 1 reject allowed
Subgroup 2 Moisture resistance, max. $\Delta R = 0.02 \%$	Subaroun 0	
	Subgroup 2	
DWV (300 V _{RMS} , 100 V/s, 1 min, $\Delta R = 0.01 \%$		
Insulation resistance (500 V _{DC} , 2 min, 100 MΩ) 12 pieces (6 high, 6 low), 1 reject allowed		
Dielectric withstanding voltage (DWV) (MIL-STD-202 method 301)		
- 300 V _{RMS} , 100 V/s, 1 min (with special fixture requirements)		
RC record - $\Delta R = 0.01 \%$		
Insulation resistance (MIL-STD-202 method 302) - same fixture requirements as DWV		
- 500 V_{DC} , 2 min		
Subgroup 3 - 10 000 M Ω min.	Subgroup 3	
Low temperature storage (LTS) (- 65 °C , 24 h, 0 W)	- •	
Low temperature operation (LTO) (- 65 °C, 45 min, rated V, not to exceed P)		
RC record - $\Delta R = 0.01$ % for both LTS and LTO		
Terminal strength (MIL-STD-202 method 211)		
Pull test (condition A, 2 lbf, 5 s to 10 s)		Pull test (condition A 2 lbf 5 s to 10 s)
Twist test (condition D)		





TABLE 4 - SC	REENING AND ENVIRONMENTAL TESTS
	9 pieces (any value), 0 rejects
Subgroup 4	Shock (method 213, condition I - 100G, 6 ms, sawtooth), ΔR = 0.01 %
	Vibration (method 204, condition D, 10 Hz to 2 kHz, 20G), ΔR = 0.01 %
	5 pieces (any value), 0 rejects
Subgroup 5	High temperature exposure (2000 h, + 175 °C, 0 W)
	RC record - $\Delta R = 0.05 \%$

TABLE 5 - QL	JALIFICATION (10R TO 100K) (when required)
Group 1	Group A
Group 2	Group B
Group 3	10 pieces (equally divided between highest and lowest values), 1 rejectTCR (per group B conditions)Low temperature storage (LTS)Low temperature operation (LTO)RC record - $\Delta R = 0.01$ % for LTS and LTOTerminal strength (per group C conditions)Pull test (condition A, 2 lbs, 5 s to 10 s)Twist test (condition D)RC record - $\Delta R = 0.01$ %
Group 4	12 pieces (equally divided between highest and lowest values), 1 reject Dielectric withstanding voltage (DWV) (MIL-STD-202 method 301) - 300 V _{RMS} , 100 V/s, 1 min RC record - $\Delta R = 0.01 \%$ Insulation resistance (MIL-STD-202 method 302) - 10 000 M Ω min. - 500 V _{DC} , 2 min Resistance to soldering heat ($\Delta R = 0.01 \%$) Moisture resistance ($\Delta R = 0.05 \%$) DWV (300 V, 1 min, $\Delta R = 0.01 \%$) Insulation resistance (500 V _{DC} , 2 min, 100 M Ω)
Group 5	10 pieces (equally divided between highest and lowest values), 1 rejectShock - (100G, 6 ms, sawtooth condition I), $\Delta R = 0.01 \%$ Vibration - (10 Hz to 2 kHz, condition D), $\Delta R = 0.01 \%$
Group 6	10 pieces (equally divided between highest and lowest values), 1 reject Solderability Resistance to solvents
Group 7	10 pieces (equally divided between highest and lowest values), 1 reject High temperature exposure (2000 h, + 175 °C, 0 W), $\Delta R = 0.05$ %
Group 8	50 pieces (equally divided between highest and lowest values), 0 reject Life - (+ 125 °C, 0.3 W, not to exceed max. voltage 245 V, 10 000 h) RC record at 250 h, 500 h, 1000 h, 2000 h, 4000 h, 6000 h, 8000 h, and 10 000 h Maximum ∆R - 0.015 % for 2000 h, 0.05 % for 10 000 h
Group 9	30 pieces (high/low) Thermal shock - 100 cycles, - 65 °C to + 150 °C, Δ R = 0.035 %
Group 10	10 pieces (highest value only) Voltage coefficient (ΔR = 1 ppm/V)

Vishay Foil Resistors



	Z201		7001	
	Z201		Z201	
1	10 Ω to 100 kΩ		10 Ω to 100 k Ω	
/alue} - {Tole	erance} - {Terminati	on} - {Packa	aging}	
Code	Termination	Code	Packaging	Code
V	Tin/lead	В	Bulk	L
Т				
Q				
A				
В				
С				
D				
	/alue} - {Tole	Zalue} - {Tolerance} - {Termination Code Termination V Tin/lead T Q A B C	Zalue} - {Tolerance} - {Termination} - {Packate Code Termination Code V Termination Code T Q A B C	Yalue} - {Tolerance} - {Termination} - {Packaging} Code Termination Code Packaging V Tin/lead B Bulk T Q A B Code A B C Code Code

Notes

⁽¹⁾ For unqualified pre-flight or prototype units, use model #303143U which includes only the 100 % screening requirements ⁽²⁾ 0.200" (5.08 mm) lead spacing available - specify 303143L



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